

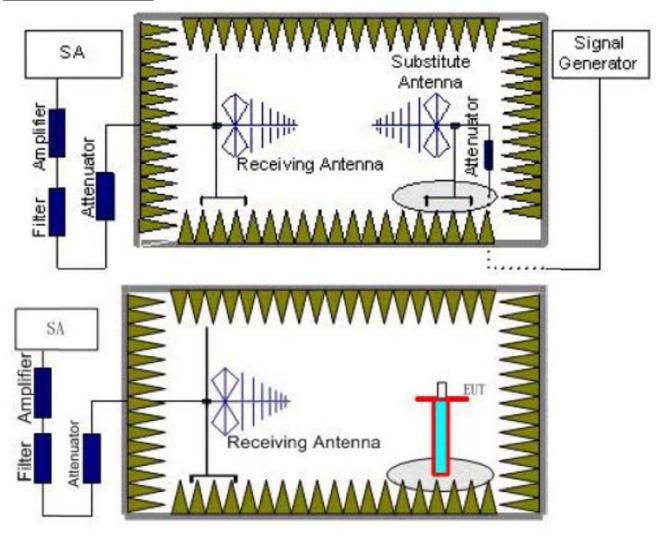
Report No: TRE1603015902 Page: 64 of 89 Issued: 2016-04-19

4.5. Radiated Power Measurement

LIMIT

LTE Band 7/17: 2W ERP LTE Band 4: 1W EIRP

TEST CONFIGURATION



TEST PROCEDURE

- 1. EUT was placed on a 1.5 meter high non-conductive stand at a 3 meter test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 meters from the EUT for emission measurements. The height of receiving antenna is 1.0m. Detected emissions were maximized at each frequency by rotating the EUT through 360° and adjusting the receiving antenna polarization. The radiated emission measurements of all transmit frequencies in three channels (High, Middle, Low) were measured with peak detector.
- 2. A log-periodic antenna or double-ridged waveguide horn antenna shall be substituted in place of the EUT. The log-periodic antenna will be driven by a signal generator and the level will be adjusted till the same power value on the spectrum analyzer or receiver. The level of the spurious emissions can be calculated through the level of the signal generator, cable loss, the gain of the substitution antenna and the reading of the spectrum analyzer or receiver.
- 3. The EUT is then put into continuously transmitting mode at its maximum power level during the test.Set Test Receiver or Spectrum RBW=1MHz,VBW=3MHz for above 1GHz and RBW=100kHz,VBW=300kHz for 30MHz to 1GHz,, And the maximum value of the receiver should be recorded as (Pr).
- 4. The EUT shall be replaced by a substitution antenna. In the chamber, an substitution antenna for the frequency band of interest is placed at the reference point of the chamber. An RF Signal source for the frequency band of interest is connected to the substitution antenna with a cable that has been constructed to not interfere with the radiation pattern of the antenna. A power (PMea) is applied to the input of the

Report No: TRE1603015902 Page: 65 of 89 Issued: 2016-04-19

substitution antenna, and adjust the level of the signal generator output until the value of the receiver reach the previously recorded (Pr). The power of signal source (PMea) is recorded. The test should be performed by rotating the test item and adjusting the receiving antenna polarization.

- 5. A amplifier should be connected to the Signal Source output port. And the cable should be connect between the Amplifier and the Substitution Antenna. The cable loss (Pcl) ,the Substitution Antenna Gain (Ga) and the Amplifier Gain (PAg) should be recorded after test.
- The measurement results are obtained as described below:
 Power(EIRP)=PMea- PAg Pcl + Ga
 We used SMF100A micowave signal generator which signal level can up to 33dBm,so we not used power Amplifier for substituation test; The measurement results are amend as described below: Power(EIRP)=PMea- Pcl + Ga
- 7. This value is EIRP since the measurement is calibrated using an antenna of known gain (2.15 dBi) and known input power.

 ERP can be calculated from EIRP by subtracting the gain of the dipole, ERP = EIRP-2.15dBi.

TEST RESULTS

Report No: TRE1603015902 Page: 66 of 89 Issued: 2016-04-19

LTE Band 4-1.4MHz									
	0	ERP	ERP (dBm)						
Modulation	Channel	Horizontal	Horizontal	Limit (dBm)	Result				
	Low	21.64	19.89						
QPSK	Mid	20.45	19.25	20	PASS				
	High	21.36	19.78						
	Low	19.75	17.47	30					
16QAM	Mid	19.38	17.32		PASS				
	High	19.49	17.16						

LTE Band 4-3MHz								
Madulation	Channel	ERP (dBm)		Limit (dRm)	Result			
Modulation	Charlie	Horizontal	Horizontal	Limit (dBm)	Mesuit			
	Low	21.43	19.84					
QPSK	Mid	20.59	19.75	20	PASS			
	High	21.32	19.86					
	Low	19.48	17.67	30				
16QAM	Mid	19.57	17.84		PASS			
	High	19.34	17.69					

LTE Band 4-5MHz								
NA - I I - C	Channal	ERP	ERP (dBm)		Result			
Modulation	Channel	Horizontal	Horizontal	Limit (dBm)	Result			
	Low	21.45	19.63					
QPSK	Mid	20.85	19.20	20	PASS			
	High	21.42	19.32					
	Low	19.33	17.43	30				
16QAM	Mid	19.79	17.65		PASS			
	High	19.36	17.74					

LTE Band 4-10MHz								
Modulation	Channel	ERP (dBm)		Limit (dBm)	Result			
Modulation	Channel	Horizontal	Horizontal	Limit (dbm)	Result			
	Low	21.26	19.66					
QPSK	Mid	21.09	19.31	20	PASS			
	High	21.34	19.69					
	Low	19.15	17.31	30				
16QAM	Mid	19.58	17.45		PASS			
	High	19.69	17.82					

Report No: TRE1603015902 Page: 67 of 89 Issued: 2016-04-19

LTE Band 4-15MHz								
Madulatian	Channel	ERP (dBm)		Limit (dPm)	Result			
Modulation	Channel	Horizontal	Horizontal	Limit (dBm)	Result			
	Low	21.02	19.42					
QPSK	Mid	21.38	19.35	20	PASS			
	High	21.66	19.59					
	Low	19.43	17.36	30				
16QAM	Mid	19.39	17.48		PASS			
	High	19.74	17.54					

LTE Band 4-20MHz								
Modulation C	Channal	ERP	ERP (dBm)		Popult			
	Channel	Horizontal	Horizontal	Limit (dBm)	Result			
	Low	20.54	19.33					
QPSK	Mid	20.09	19.47	20	PASS			
	High	20.38	19.59					
	Low	18.21	17.36	30				
16QAM	Mid	18.43	17.42		PASS			
	High	18.36	17.38					

Report No: TRE1603015902 Page: 68 of 89 Issued: 2016-04-19

LTE Band 7-5MHz									
N 4 1 1 <i>d</i>	Ch annual	ERP	ERP (dBm)		5 "				
Modulation	Channel	Horizontal	Horizontal	Limit (dBm)	Result				
	Low	19.73	17.43						
QPSK	Mid	19.47	17.23	22	PASS				
	High	19.58	17.35						
	Low	17.84	16.03	- 33					
16QAM	Mid	17.46	15.16		PASS				
	High	17.39	15.49						

LTE Band 7-10MHz									
Madulatian	Channel	ERP (dBm)		Limit (dPm)	Result				
Modulation	Channel	Horizontal	Horizontal	Limit (dBm)	Result				
	Low	18.47	16.87						
QPSK	Mid	19.01	17.00		PASS				
	High	19.25	17.19						
	Low	17.32	16.31	- 33					
16QAM	Mid	16.47	15.94		PASS				
	High	17.38	15.89						

LTE Band 7-15MHz								
Madriatian	Channel	ERP (c		Limit (dDm)	Result			
Modulation	Channel	Horizontal	Horizontal	Limit (dBm)	Resuit			
	Low	19.26	17.43					
QPSK	Mid	19.39	17.23	22	PASS			
	High	19.85	17.35					
	Low	17.69	15.63	33				
16QAM	Mid	17.77	15.79		PASS			
	High	17.25	15.42					

LTE Band 7-20MHz								
Madulation	Channel	ERP (dBm)		Limit (dPm)	Pocult			
Modulation	Channel	Horizontal	Horizontal	Limit (dBm)	Result			
	Low	19.28	17.25					
QPSK	Mid	19.69	17.43		PASS			
	High	19.72	17.59	33				
	Low	17.83	16.86	33				
16QAM	Mid	17.49	15.66		PASS			
	High	17.32	15.74					

Report No: TRE1603015902 Page: 69 of 89 Issued: 2016-04-19

LTE Band 17-5MHz								
Madulatian	01	ERP (dBm)		Limit (dPm)	Result			
Modulation	Channel	Horizontal	Horizontal	Limit (dBm)	Nesuit			
	Low	20.27	18.05					
QPSK	Mid	20.82	19.14		PASS			
	High	20.52	18.33					
	Low	19.43	16.64	33				
16QAM	Mid	19.37	16.48		PASS			
	High	19.05	16.85					

LTE Band 17-10MHz								
NA - I I-C	Channal	ERP	ERP (dBm)		D !!			
Modulation	Channel	Horizontal	Horizontal	Limit (dBm)	Result			
	Low	20.48	18.32					
QPSK	Mid	20.22	18.14	22	PASS			
	High	20.39	18.53					
	Low	19.52	16.69	33				
16QAM	Mid	19.47	16.36		PASS			
	High	19.86	16.79					

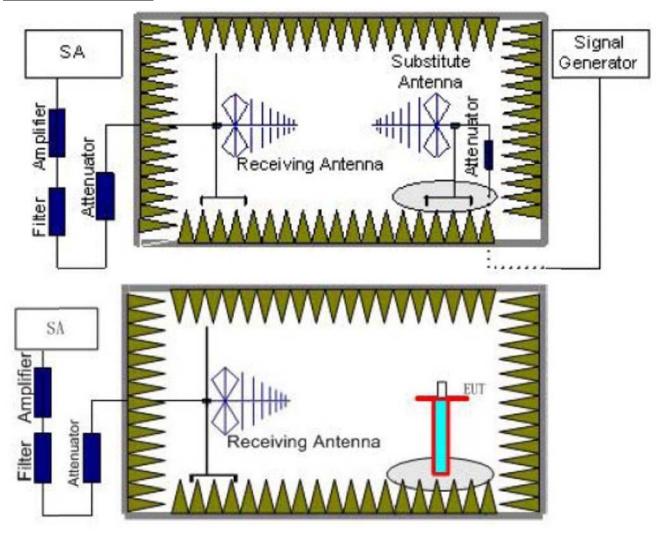
Report No: TRE1603015902 Page: 70 of 89 Issued: 2016-04-19

4.6. Radiated Spurious Emssion

LIMIT

-13dBm

TEST CONFIGURATION



TEST RESULTS

- 1. EUT was placed on a 1.5 meter high non-conductive stand at a 3 meter test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 meters from the EUT for emission measurements. The height of receiving antenna is 1.0m. Detected emissions were maximized at each frequency by rotating the EUT through 360° and adjusting the receiving antenna polarization. The radiated emission measurements of all transmit frequencies in three channels (High, Middle, Low) were measured with peak detector.
- 2. A log-periodic antenna or double-ridged waveguide horn antenna shall be substituted in place of the EUT. The log-periodic antenna will be driven by a signal generator and the level will be adjusted till the same power value on the spectrum analyzer or receiver. The level of the spurious emissions can be calculated through the level of the signal generator, cable loss, the gain of the substitution antenna and the reading of the spectrum analyzer or receiver.
- 3. The EUT is then put into continuously transmitting mode at its maximum power level during the test.Set Test Receiver or Spectrum RBW=1MHz,VBW=3MHz for above 1GHz and RBW=100kHz,VBW=300kHz for 30MHz to 1GHz, And the maximum value of the receiver should be recorded as (Pr).
- 4. The EUT shall be replaced by a substitution antenna. In the chamber, an substitution antenna for the frequency band of interest is placed at the reference point of the chamber. An RF Signal source for the frequency band of interest is connected to the substitution antenna with a cable that has been constructed to not interfere with the radiation pattern of the antenna. A power (PMea) is applied to the input of the substitution antenna, and adjust the level of the signal generator output until the value of the receiver reach the previously recorded (Pr). The power of signal source (PMea) is recorded. The test should be

Report No: TRE1603015902 Page: 71 of 89 Issued: 2016-04-19

performed by rotating the test item and adjusting the receiving antenna polarization.

5. A amplifier should be connected to the Signal Source output port. And the cable should be connect between the Amplifier and the Substitution Antenna. The cable loss (Pcl) ,the Substitution Antenna Gain (Ga) and the Amplifier Gain (PAg) should be recorded after test.

- 6. The measurement results are obtained as described below: Power(EIRP)=PMea- PAg - Pcl + Ga We used SMF100A micowave signal generator which signal level can up to 33dBm,so we not used power Amplifier for substituation test; The measurement results are amend as described below: Power(EIRP)=PMea- Pcl + Ga
- 7. This value is EIRP since the measurement is calibrated using an antenna of known gain (2.15 dBi) and known input power.
 ERP can be calculated from EIRP by subtracting the gain of the dipole, ERP = EIRP-2.15dBi.

TEST RESULTS

Report No: TRE1603015902 Page: 72 of 89 Issued: 2016-04-19

		LTE Ban	d 4-1.4MHz		
Channel	Frequency Spurious		Emission	11 11 (15)	
	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	3421.4	Vertical	-38.52		Pass
	5132.1	V	-45.75		
	6842.8	V	-50.65	-13.00	
	8553.5	V	-55.47		
Laur	10264.2	V			
Low	3421.4	Horizontal	-42.36		Pass
	5132.1	Н	-46.74		
	6842.8	Н	-51.52	-13.00	
	8553.5	Н	-55.38		
	10264.2	Н			
	3465	Vertical	-37.54	-13.00	Pass
	5197.5	V	-44.63		
	6930	V	-50.85		
	8662.5	V	-55.74		
Mid	10395	V			
IVIIG	3465	Horizontal	-43.63	-13.00	Pass
	5197.5	Н	-46.42		
	6930	Н	-52.08		
	8662.5	Н	-55.47		
	10395	Н			
High	3508.6	Vertical	-38.36	-13.00	Pass
	5262.9	V	-46.49		
	7017.2	V	-50.25		
	8771.5	V	-55.82		
	10525.8	V			
	3508.6	Horizontal	-43.38	-13.00	Pass
	5262.9	Н	-46.59		
	7017.2	Н	-51.46		
	8771.5	Н	-55.72		
	10525.8	Н			

Remark:

Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report. 1. 2.

Report No: TRE1603015902 Page: 73 of 89 Issued: 2016-04-19

		LTE Bai	nd 4-3MHz		
Channel	Frequency	Spurious	Spurious Emission		D
	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	3423	Vertical	-36.28		Pass
	5134.5	V	-45.79		
	6846	V	-50.42	-13.00	
	8557.5	V	-54.38		
Low	10269	V			
LOW	3423	Horizontal	-40.54		Pass
	5134.5	Н	-45.73		
	6846	Н	-50.65	-13.00	
	8557.5	Н	-55.82		
	10269	Н			
	3465	Vertical	-39.95	-13.00	Pass
	5197.5	V	-44.85		
	6930	V	-50.36		
	8662.5	V	-55.78		
N 4: -I	10395	V			
Mid	3465	Horizontal	-44.36	-13.00	Pass
	5197.5	Н	-46.32		
	6930	Н	-50.38		
	8662.5	Н	-55.15		
	10395	Н			
	3507	Vertical	-37.47	-13.00	Pass
	5260.5	V	-46.52		
	7014	V	-50.86		
LEads	8767.5	V	-55.25		
	10521	V			
High	3507	Horizontal	-40.63	-13.00	Pass
	5260.5	Н	-46.25		
	7014	Н	-50.78		
	8767.5	Н	-55.49		
	10521	Н			

Remark:

- 1. 2. Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report.

Report No: TRE1603015902 Page: 74 of 89 2016-04-19 Issued:

		LTE Bar	nd 4-5MHz		
Channel	Frequency Spurious		Emission		5
	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	3425	Vertical	-40.14		Pass
	5137.5	V	-46.74		
	6850	V	-50.89	-13.00	
	8562.5	V	-55.63		
1	10275	V			
Low	3425	Horizontal	-43.47		Pass
	5137.5	Н	-46.64		
	6850	Н	-50.38	-13.00	
	8562.5	Н	-55.59		
	10275	Н			
	3465	Vertical	-39.75		Pass
	5197.5	V	-44.28	-13.00	
	6930	V	-50.59		
	8662.5	V	-55.86		
Mid	10395	V			
IVIIG	3465	Horizontal	-43.52	-13.00	Pass
	5197.5	Н	-46.66		
	6930	Н	-50.37		
	8662.5	Н	-54.83		
	10395	Н			
	3505	Vertical	-38.52	-13.00	Pass
	5257.5	V	-46.52		
	7010	V	-50.74		
	8762.5	V	-55.66		
∐iab	10515	V			
High	3505	Horizontal	-41.58	-13.00	Pass
	5257.5	Н	-46.74		
	7010	Н	-49.85		
	8762.5	Н	-55.67		
	10515	Н			

Remark:

- Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report. 1. 2.

		LTE Ban	d 4-10MHz		
Channel	Frequency	Spurious	Spurious Emission		
	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	3430	Vertical	-40.25		Pass
	5145	V	-47.84		
	6860	V	-50.86	-13.00	
	8575	V	-56.43		
Low	10290	V			
LOW	3430	Horizontal	-46.38		Pass
	5145	Н	-48.45		
	6860	Н	-50.84	-13.00	
	8575	Н	-55.49		
	10290	Н			
	3465	Vertical	-39.21		Pass
	5197.5	V	-46.88	-13.00	
	6930	V	-50.27		
	8662.5	V	-56.69		
Mid	10395	V			
IVIIQ	3465	Horizontal	-43.52	-13.00	Pass
	5197.5	Н	-48.84		
	6930	Н	-49.84		
	8662.5	Н	-55.66		
	10395	Н			
	3500	Vertical	-40.59	-13.00	Pass
	5250	V	-47.49		
	7000	V	-50.37		
	8750	V	-56.52		
High	10500	V			
i ligii	3500	Horizontal	-45.75	-13.00	
	5250	Н	-47.66		
	7000	Н	-49.76		Pass
	8750	Н	-56.83		
	10500	Н			

Remark:

1. 2.

Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report.

		LTE Ban	d 4-15MHz		
Channel	Frequency	Spurious Emission			
	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	3435	Vertical	-40.49		Pass
	5152.5	V	-45.75		
	6870	V	-49.84	-13.00	
	8587.5	V	-55.69		
Low	10305	V			
LOW	3435	Horizontal	-45.38		Pass
	5152.5	Н	-47.42		
	6870	Н	-50.92	-13.00	
	8587.5	Н	-55.23		
	10305	Н			
	3465	Vertical	-40.28	-13.00	Pass
	5197.5	V	-45.76		
	6930	V	-49.02		
	8662.5	V	-55.15		
Mid	10395	V			
IVIIU	3465	Horizontal	-44.66	-13.00	Pass
	5197.5	Н	-47.24		
	6930	Н	-50.39		
	8662.5	Н	-55.23		
	10395	Н			
	3495	Vertical	-40.54	-13.00	Pass
	5242.5	V	-45.23		
	6990	V	-49.41		
	8737.5	V	-55.35		
High	10485	V			
riigii	3495	Horizontal	-45.42	-13.00	Pass
	5242.5	Н	-47.35		
	6990	Н	-50.97		
	8737.5	Н	-56.25		
	10485	Н			

Remark:

Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report. 1. 2.

Report No: TRE1603015902 Page: 77 of 89 Issued: 2016-04-19

		LTE Ban	d 4-20MHz		
	Frequency	Spurious	Emission		5
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	3440	Vertical	-40.43		
	5160	V	-46.59		
	6880	V	-49.74	-13.00	Pass
	8600	V	-55.85		
Lavi	10320	V			
Low	3440	Horizontal	-44.52		
	5160	Н	-47.58		
	6880	Н	-50.63	-13.00	Pass
	8600	Н	-55.47		
	10320	Н			
	3465	Vertical	-40.25		Pass
	5197.5	V	-45.66		
	6930	V	-49.37	-13.00	
	8662.5	V	-55.47]	
N 4: -I	10395	V			
Mid	3465	Horizontal	-43.25		Pass
	5197.5	Н	-46.82		
	6930	Н	-50.59	-13.00	
	8662.5	Н	-55.28		
	10395	Н			
	3490	Vertical	-41.79		
	5235	V	-46.25		
	6980	V	-49.43	-13.00	Pass
	8725	V	-55.08		
Llimb	10470	V			
High	3490	Horizontal	-45.25		
	5235	Н	-47.37		
	6980	Н	-50.59	-13.00	Pass
	8725	Н	-55.82		
	10470	Н			

- 1.
- Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report.

Report No: TRE1603015902 Page: 78 of 89 Issued: 2016-04-19

		LTE Bai	nd 7-5MHz		
01	Frequency	Spurious	Emission	1:::::(15)	D "
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	5005	Vertical	-44.25		
	7507.5	V	-46.38		
	10010	V	-50.47	-13.00	Pass
	12512.5	V			
Lave	15015	V			
Low	5005	Horizontal	-45.86		
	7507.5	Н	-47.85		
	10010	Н	-51.45	-13.00	Pass
	12512.5	Н			
	15015	Н			
	5070	Vertical	-45.38		
	7605	V	-46.45		Pass
	10140	V	-49.85	-13.00	
	12675	V			
Mid	15210	V			
IVIIQ	5070	Horizontal	-46.25		
	7605	Н	-48.36		Pass
	10140	Н	-51.42	-13.00	
	12675	Н			
	15210	Н			
	5135	Vertical	-44.85		
	7702.5	V	-46.39		
	10270	V	-50.32	-13.00	Pass
	12837.5	V			
	15405	V			
High	5135	Horizontal	-46.24		
	7702.5	Н	-47.49		
	10270	Н	-50.45	-13.00	Pass
	12837.5	Н			
	15405	Н			

- 1.
- Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report. 2.

Report No: TRE1603015902 Page: 79 of 89 Issued: 2016-04-19

		LTE Ban	d 7-10MHz		
01 1	Frequency	Spurious	Emission	1: :: (15.)	D ''
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	5010	Vertical	-46.25		
	7515 V -4	-46.89			
	10020	V	-49.52	-13.00	Pass
	12525	V			
Low	15030	V			
LOW	5010	Horizontal	-47.47		
	7515	Н	-47.76		
	10020	Н	-50.83	-13.00	Pass
	12525	Н			
	15030	Н			
	5070	Vertical	-45.49		
	7605	V	-46.59		
	10140	V	-49.94	-13.00	Pass
	12675	V]	
Mid	15210	V			
iviid	5070	Horizontal	-47.35		Pass
	7605	Н	-47.46		
	10140	Н	-50.39	-13.00	
	12675	Н			
	15210	Н			
	5130	Vertical	-46.27		
	7695	V	-46.58		
	10260	V	-49.06	-13.00	Pass
	12825	V			
High	15390	V			
riigii	5130	Horizontal	-46.25		
	7695	Н	-47.36		
	10260	Н	-50.44	-13.00	Pass
	12825	Н			
	15390	Н			

- 1.
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Report No: TRE1603015902 Page: 80 of 89 Issued: 2016-04-19

		LTE Ban	d 7-15MHz		
Observati	Frequency	Spurious	Emission	Livit (dD m)	D II
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	5015	Vertical	-45.65		
	7522.5	V	-46.47		
	10030	V	-49.85	-13.00	Pass
	12537.5	V			
Low	15045	V			
LOW	5015	Horizontal	-46.44		
	7522.5	Н	-46.43		
	10030	Н	-50.93	-13.00	Pass
	12537.5	Н			
	15045	Н			
	5070	Vertical	-46.35		Pass
	7605	V	-46.66		
	10140	V	-49.43	-13.00	
	12675	V]	
Mid	15210	V			
IVIIG	5070	Horizontal	-47.38		
	7605	Н	-46.24		
	10140	Н	-50.66	-13.00	Pass
	12675	Н			
	15210	Н			
	5125	Vertical	-46.61		
	7687.5	V	-46.85		
	10250	V	-50.36	-13.00	Pass
	12812.5	V			
Lliab	15375	V			
High	5125	Horizontal	-46.27		
	7687.5	Н	-47.48		
	10250	Н	-50.19	-13.00	Pass
	12812.5	Н			
	15375	Н			

- Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report.

Report No: TRE1603015902 Page: 81 of 89 Issued: 2016-04-19

		LTE Ban	d 7-20MHz		
01 1	Frequency	Spurious	Emission	1: ': (1D)	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	5020	Vertical	-45.88		
	7530	V	-45.74		
	10040	V	-49.59	-13.00	Pass
	12550	V			
Low	15060	V			
LOW	5020	Horizontal	-46.38		
	7530	Н	-46.52		
	10040	Н	-50.96	-13.00	Pass
	12550	Н			
	15060	Н			
	5070	Vertical	-45.72		00 Pass
	7605	V	-45.25		
	10140	V	-49.04	-13.00	
	12675	V			
Mid	15210	V			
IVIIO	5070	Horizontal	-46.31		Pass
	7605	Н	-45.39		
	10140	Н	-50.24	-13.00	
	12675	Н			
	15210	Н			
	5120	Vertical	-44.75		
	7680	V	-43.42		
	10240	V	-50.36	-13.00	Pass
	12800	V			
Lliah	15360	V			
High	5120	Horizontal	-45.75		
	7680	Н	-45.66		
	10240	Н	-49.58	-13.00	Pass
	12800	Н			
	15360	Н			

- 1.
- Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report. 2.

Report No: TRE1603015902 Page: 82 of 89 2016-04-19 Issued:

		LTE Ban	d 17-5MHz			
Channel	Frequency	Spurious	Emission	Limeit (dDms)	Decult	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
	1413	Vertical	-38.45			
	2119.5	V	-44.25			
	2826	V	-45.74	-13.00	Pass	
	3532.5	V	-61.74			
Low	4239	V				
LOW	1413	Horizontal	-42.58			
	2119.5	Н	-48.47			
	2826	Н	-48.47	-13.00	Pass	
	3532.5	Н	-63.79			
	4239	Н				
	1420	Vertical	-39.48		Pass	
	2130	V	-44.44			
	2840	V	-45.68	-13.00		
	3550	V	-60.87]		
Mid	4260	V				
IVIIQ	1420	Horizontal	-43.47		3.00 Pass	
	2130	Н	-48.32			
	2840	Н	-49.28	-13.00		
	3550	Н	-62.63			
	4260	Н				
	1427	Vertical	-40.25			
	2140.5	V	-44.66			
	2854	V	-45.37	-13.00	Pass	
	3567.5	V	-60.78			
Lliab	4281	V				
High	1427	Horizontal	-42.25			
	2140.5	Н	-48.36			
	2854	Н	-48.43	-13.00	Pass	
	3567.5	Н	-63.52			
	4281	Н				

- 1. 2.
- Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report.

Report No: TRE1603015902 Page: 83 of 89 2016-04-19 Issued:

		LTE Band	d 17-10MHz		
01 1	Frequency	Spurious	Emission	L''((JD)	D 11
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	1418	Vertical	-37.85		
	2127	V	-45.27		
	2836	V	-46.74	-13.00	Pass
	3545	V	-60.25]	
Low	4254	V			
LOW	1418	Horizontal	-41.53		
	2127	Н	-47.43		
	2836	Н	-48.59	-13.00	Pass
	3545	Н	-60.78		
	4254	Н			
	1420	Vertical	-39.43		
	2130	V	-44.27		
	2840	V	-45.08	-13.00	Pass
	3550	V	-60.75		
Mid	4260	V			
IVIIQ	1420	Horizontal	-42.41		Pass
	2130	Н	-48.52		
	2840	Н	-49.43	-13.00	
	3550	Н	-62.39		
	4260	Н			
	1422	Vertical	-41.58		
	2133	V	-45.46		
	2844	V	-45.36	-13.00	Pass
	3555	V	-60.66		
∐iah	4266	V			
High	1422	Horizontal	-43.49		
	2133	Н	-47.57		
	2844	Н	-48.36	-13.00	Pass
	3555	Н	-62.88		
	4266	Н			

- Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report. 1. 2.

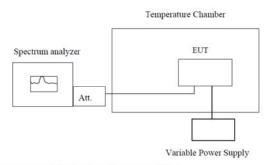
Report No: TRE1603015902 Page: 84 of 89 Issued: 2016-04-19

4.7. Frequency stability V.S. Temperature measurement

LIMIT

2.5ppm

TEST CONFIGURATION



Note: Measurement setup for testing on Antenna connector

TEST PROCEDURE

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators.
- 3. The EUT was placed inside the temperature chamber.
- 4. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25℃ operating frequency as reference frequency.
- 5. Turn EUT off and set the chamber temperature to −30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency.
- 6. Repeat step measure with 10℃ increased per stage until the highest temperature of +50℃ reached.

TEST RESULTS

Report No: TRE1603015902 Page: 85 of 89 Issued: 2016-04-19

Referen	ce Frequency: LTE Ba	and 4 Middle char	nel=1732.5MHz	,20MHz Bandwidt	h
Power supplied	Temperature (°C)	Frequer	ncy error	Limit (ppm)	Result
(Vdc)	remperature (C)	Hz	ppm	Limit (ppm)	Result
	-30	18	0.0104		
	-20	15	0.0087		
	-10	8	0.0046		
	0	12	0.0069		
3.80	10	25	0.0144	2.5	Pass
	20	16	0.0092		
	30	27	0.0156	7	
	40	28	0.0162	1	
	50	32	0.0185		
Refere	nce Frequency: LTE B		nnel=2535MHz,2	20MHz Bandwidth	
Power supplied	Town a voture (°C)	Frequer	ncy error	Lineit (n.n.m)	Daguit
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
	-30	25	0.0099		
	-20	14	0.0055		
	-10	31	0.0122	7	
	0	15	0.0059	7	
3.80	10	26	0.0103	2.5	Pass
	20	18	0.0071	7	
	30	22	0.0087	1	
	40	17	0.0067		
	50	26	0.0103		
Referer	nce Frequency: LTE E	L	annel=710MHz,	10MHz Bandwidth	
Power supplied	Town a voture (°C)	Frequer	ncy error	Lineit (n.n.m.)	Daguit
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
	-30	32	0.0451		
	-20	15	0.0211	7	
	-10	29	0.0408		
	0	34	0.0479		
3.80	10	15	0.0211	2.5	Pass
-	20	28	0.0394	7	
	30	17	0.0239	7	
	40	22	0.0310	7	
	50	16	0.0225	7	

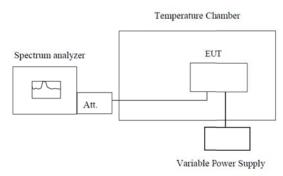
Report No: TRE1603015902 Page: 86 of 89 Issued: 2016-04-19

4.8. Frequency stability V.S. Voltage measurement

LIMIT

2.5ppm

TEST CONFIGURATION



Note: Measurement setup for testing on Antenna connector

TEST PROCEDURE

- 1. Set chamber temperature to 25° C. Use a variable DC power source to power the EUT and set the voltage to rated voltage.
- 2. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.
- 3. Reduce the input voltage to specified extreme voltage variation (+/- 15%) and endpoint, record the maximum frequency change.

TEST RESULTS

Reference Frequency: LTE Band 4 Middle channel=1732.5MHz,20MHz Bandwidth								
Temperature (°C)	Power supplied	Frequer	ncy error	Limit (ppm)	Result			
remperature (C)	(Vdc)	Hz	ppm	Limit (ppm)	Nesuit			
	4.37	15	0.0087					
25	3.80	22	0.0127	2.5	Pass			
	3.23	14	0.0081					
Referen	ce Frequency: LTE B	and 7 Middle cha	nnel=2535MHz,20	OMHz Bandwidth				
Temperature (°C)	Power supplied	Frequency error		Limit (ppm)	Result			
remperature (c)	(Vdc)	Hz	ppm	Limit (ppm)	resuit			
	4.37	18	0.0071					
25	3.80	21	0.0083	2.5	Pass			
	3.23	9	0.0036					
Referen	ce Frequency: LTE B	and 17 Middle ch	annel=710MHz,10	OMHz Bandwidth				
Temperature (°C)	Power supplied	Frequer	ncy error	Limit (ppm)	Result			
remperature (C)	(Vdc)	Hz	ppm	Limit (ppm)	Nesuit			
	4.37	19	0.0268					
25	3.80	10	0.0141	2.5	Pass			
	3.23	22	0.0310					

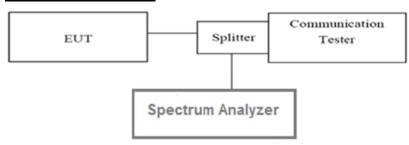
Report No: TRE1603015902 Page: 87 of 89 Issued: 2016-04-19

4.9. Peak-Average Ratio

LIMIT

13dB

TEST CONFIGURATION



TEST PROCEDURE

According with KDB 971168

- 1. The signal analyzer's CCDF measurement profile is enabled
- 2. Frequency = carrier center frequency
- 3. Measurement BW > Emission bandwidth of signal
- 4. The signal analyzer was set to collect one million samples to generate the CCDF curve
- 5. The measurement interval was set depending on the type of signal analyzed. For continuous signals(>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power

TEST RESULTS

LTE Band 4-20MHz										
Modulation	QPS	SK	16QAM		Limi#/dD)	Dogult				
Channel	1RB#	Full RB#	1RB#	Full RB#	Limi t (dB)	Result				
Low	4.25	4.98	4.32	4.38	13	Pass				
Mid	4.36	4.63	4.12	4.12	13	Pass				
High	3.74	4.24	4.36	5.98	13	Pass				

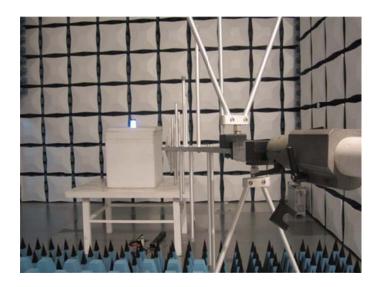
LTE Band 7-20MHz										
Modulation	QPSK		16QAM		Limit/dD)	Dooult				
Channel	1RB#	Full RB#	1RB#	Full RB#	Limi t (dB)	Result				
Low	2.84	8.04	4.10	5.47	13	Pass				
Mid	3.36	4.78	3.68	5.59	13	Pass				
High	3.70	4.48	4.44	5.49	13	Pass				

LTE Band 17-10MHz										
Modulation	QPS	SK	16QAM		Limit(dB)	Result				
Channel	1RB#	Full RB#	1RB#	Full RB#	Liffiit(ab)	Result				
Low	3.44	4.67	4.53	5.43	13	Pass				
Mid	3.02	4.52	4.85	5.63	13	Pass				
High	2.74	4.83	3.62	5.57	13	Pass				

Report No: TRE1603015902 Page: 88 of 89 Issued: 2016-04-19

5. Test Setup Photos of the EUT

Radiated emission:





Report No: TRE1603015902 Page: 89 of 89 Issued: 2016-04-19

6. External and Internal Photos of the EUT

Reference to the test report No.	TRE1603015901
	End of Report